

Search Notes

Application/Control No.

10/519,027

Examiner

VAN T. PHAM

Applicant(s)/Patent under
Reexamination

OHYAMA, MINORU

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
369	112.16, 121.	5/26/2006 <i>updated on 10/03/06</i>	VP <i>VP.</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB	text sear	10/3/2006	VP
Interference search (See search history printout).			

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB) 369, (text search only see search history printout).	10/3/2006	VP
Consulted WayneYoung.	10/3/2006	VP